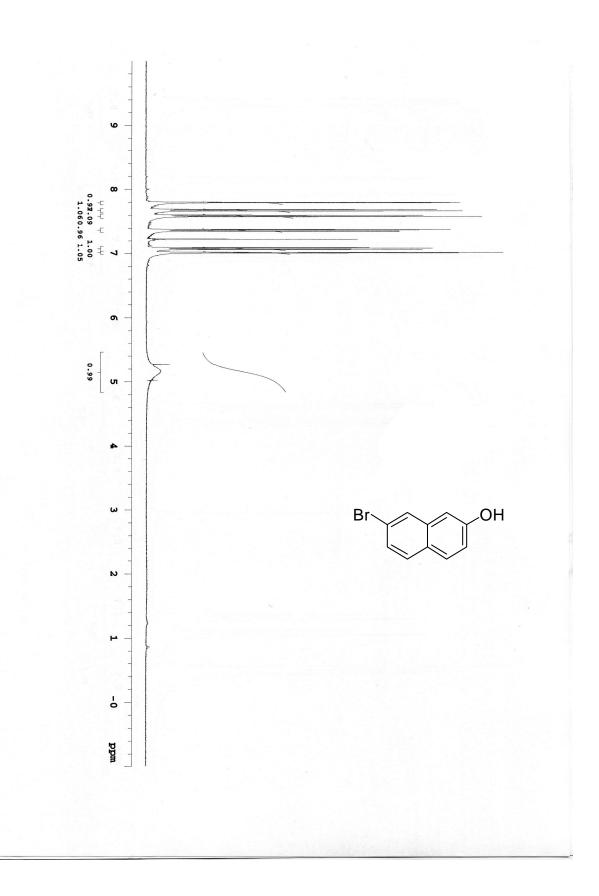
Light-Controlled Supramolecular Helicity of a Liquid Crystalline Phase Using a Helical Polymer Functionalized with a Single Chiroptical Molecular Switch.

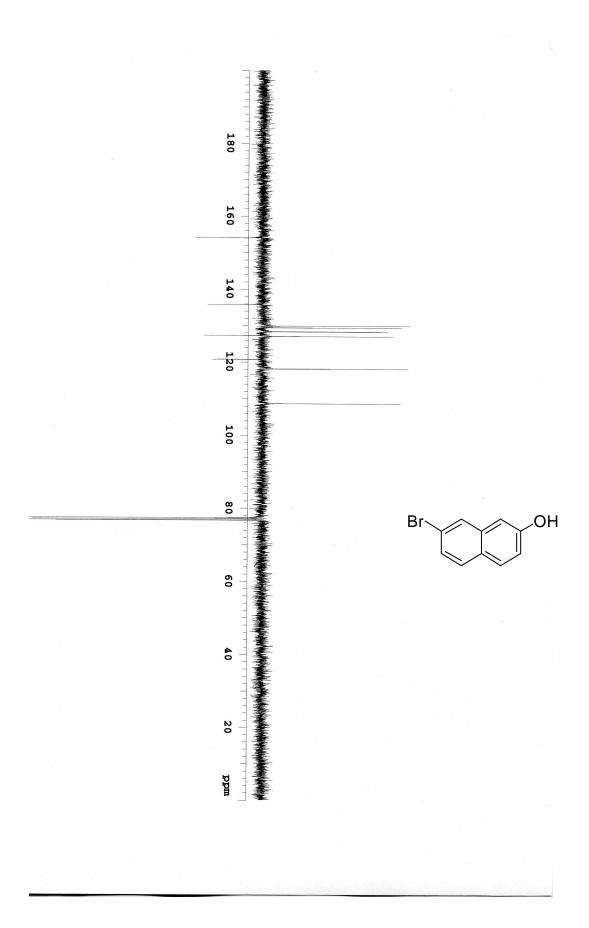
Dirk Pijper, Mahthild G. M. Jongejan, Auke Meetsma and Ben L. Feringa*

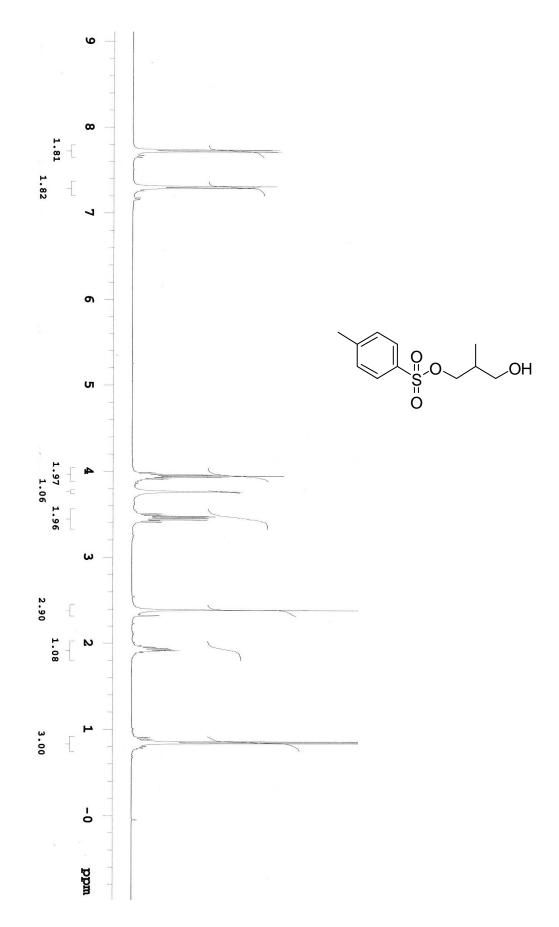
Department of Organic and Molecular Inorganic Chemistry, Stratingh Institute,

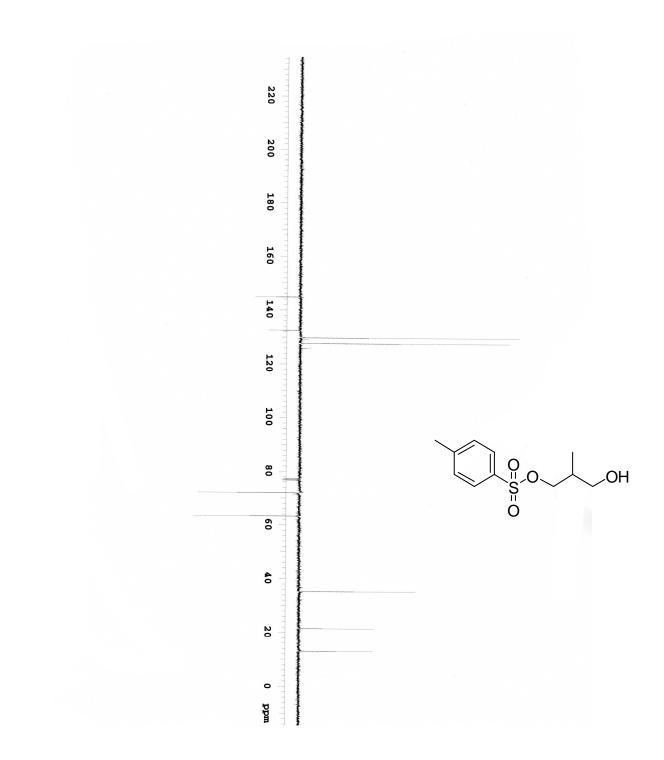
University of Groningen, Nijenborgh 4, 9747 AG, Groningen, The Netherlands

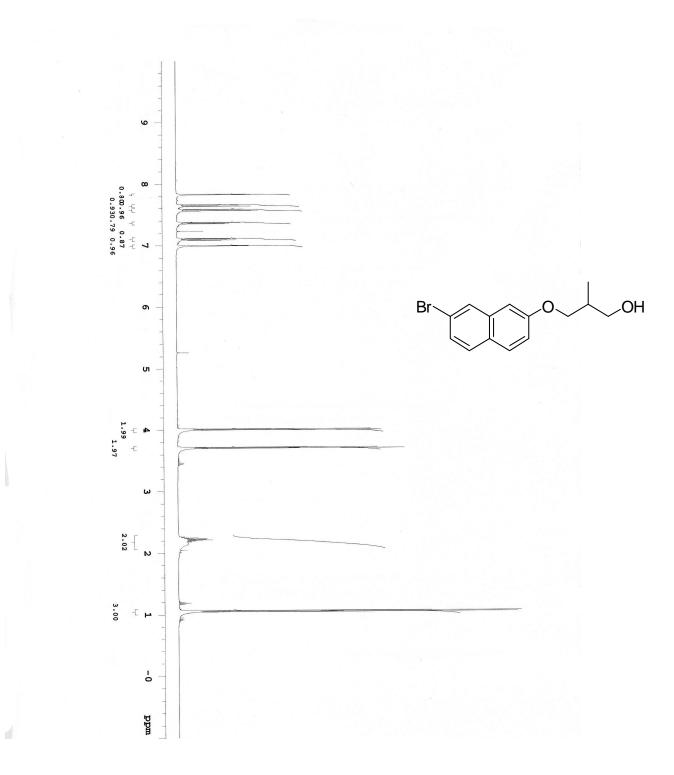
Fax: (+31)50-363-4296 E-mail: b.l.feringa@rug.nl

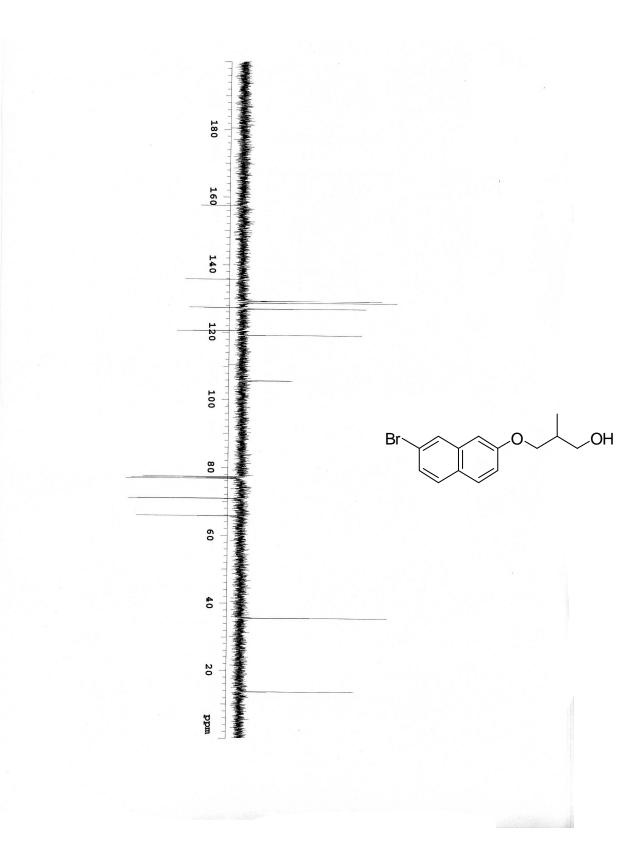


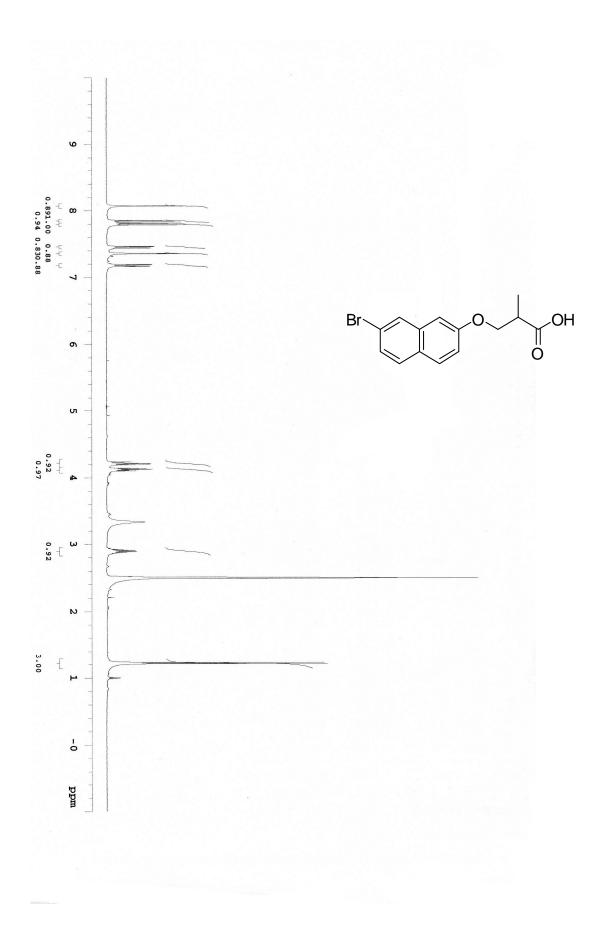


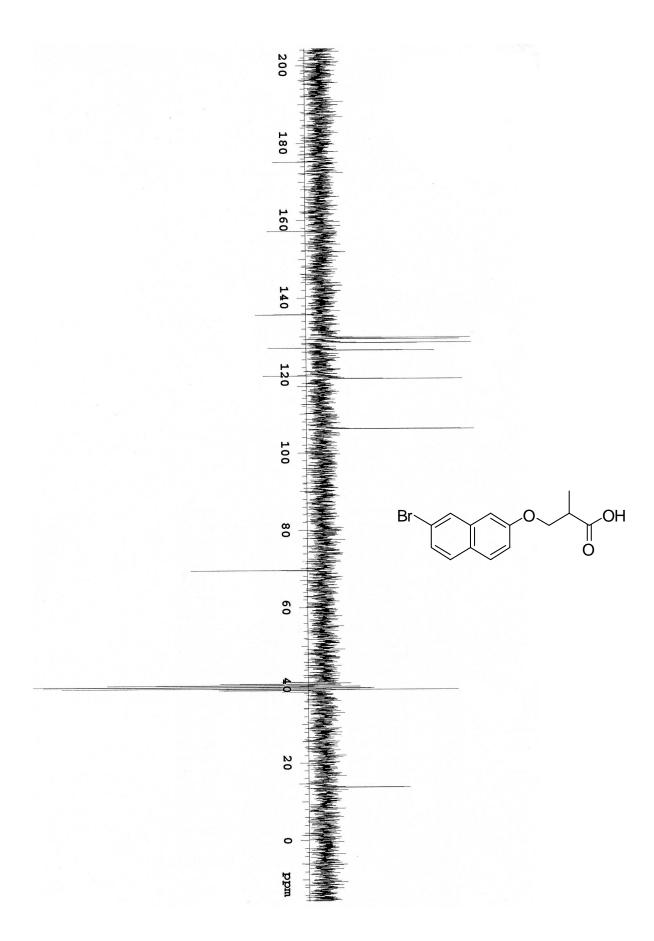


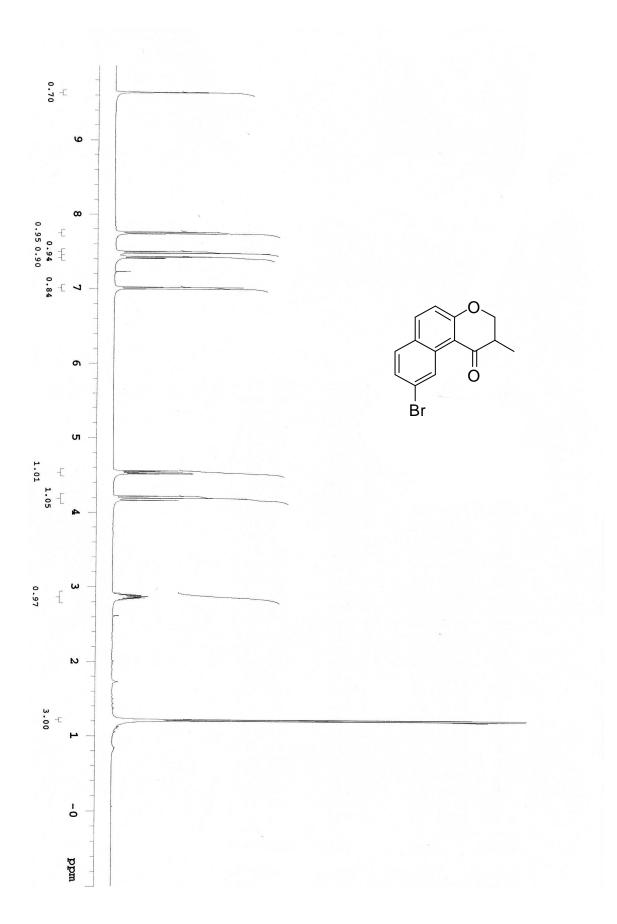


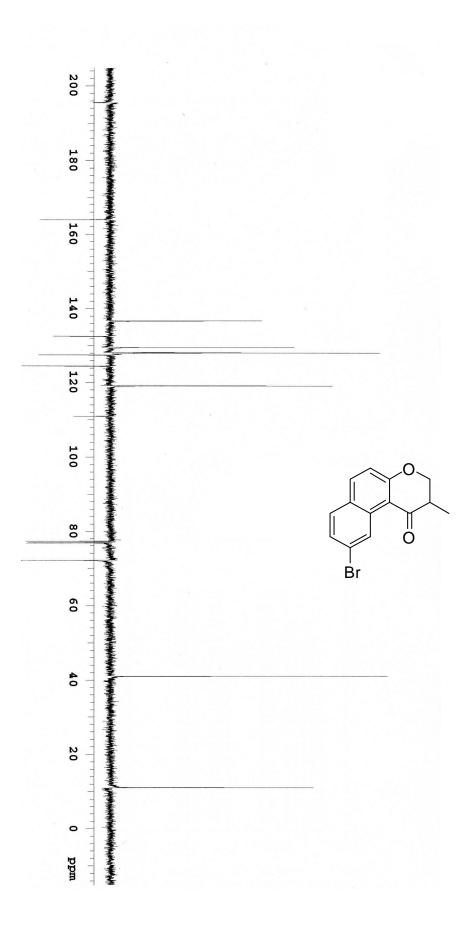


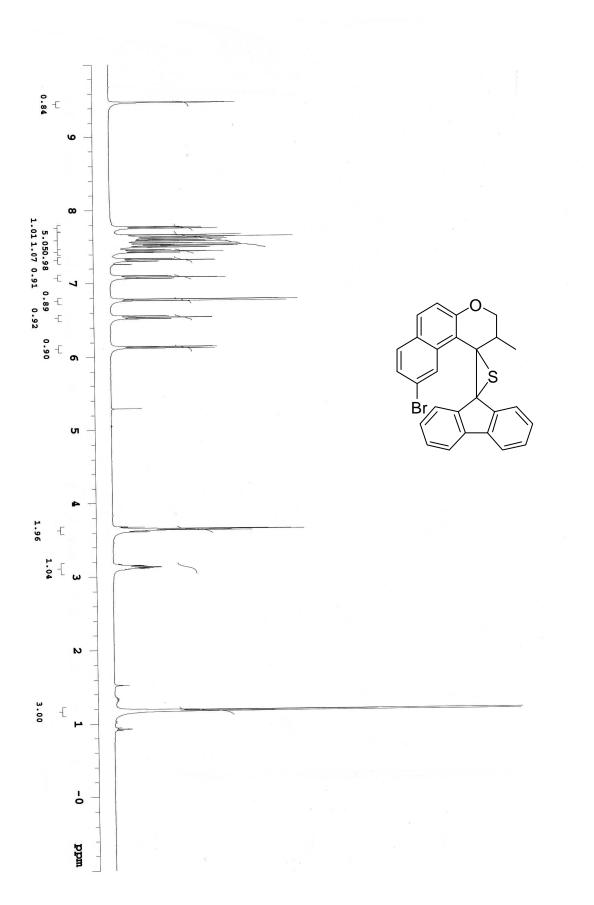


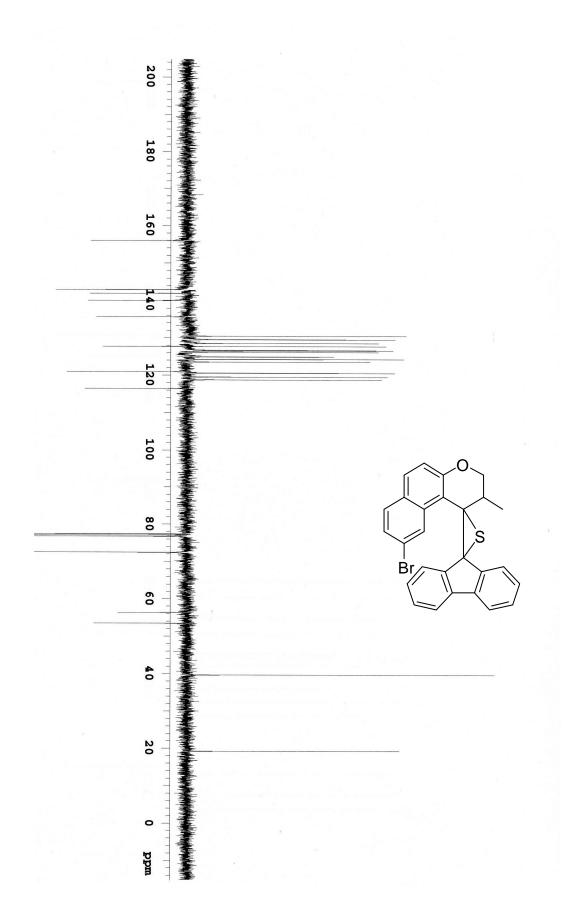


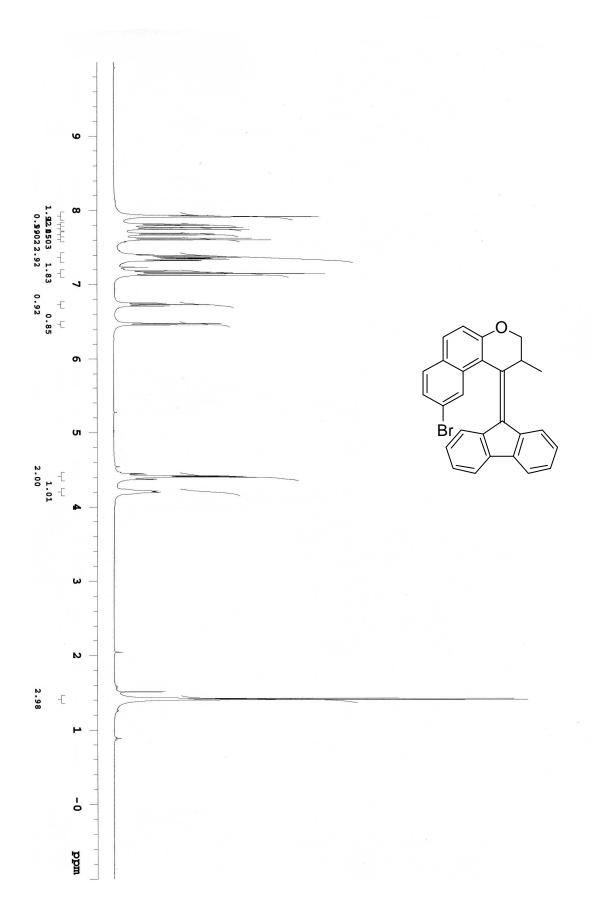


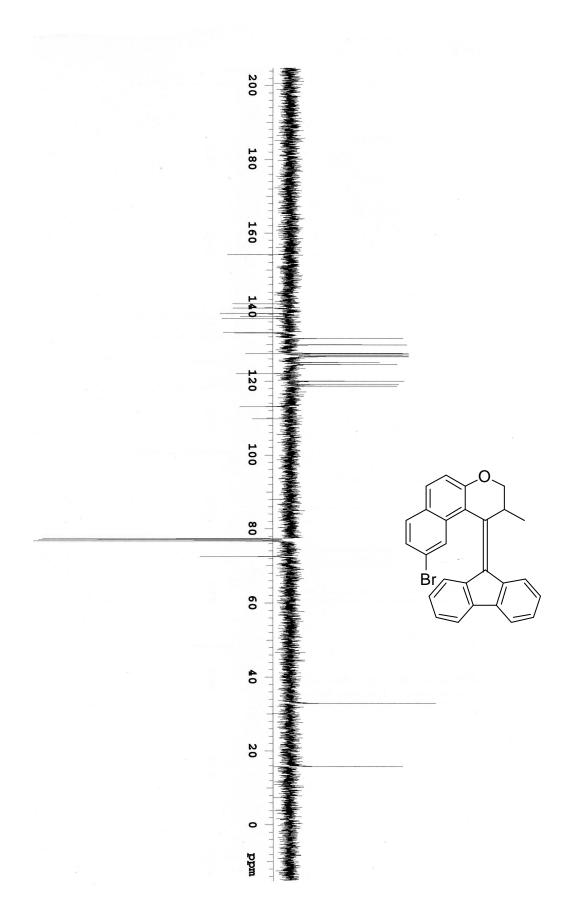


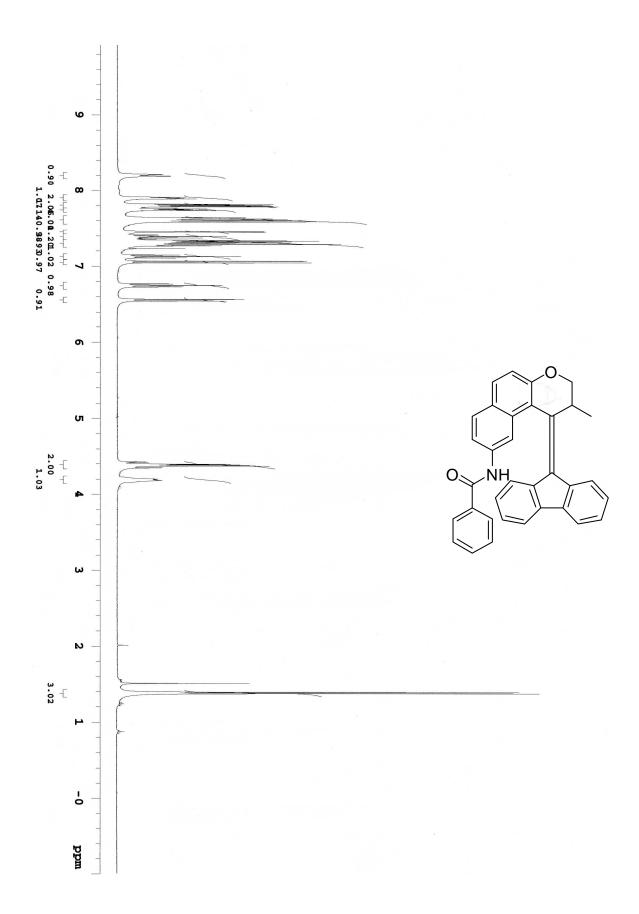


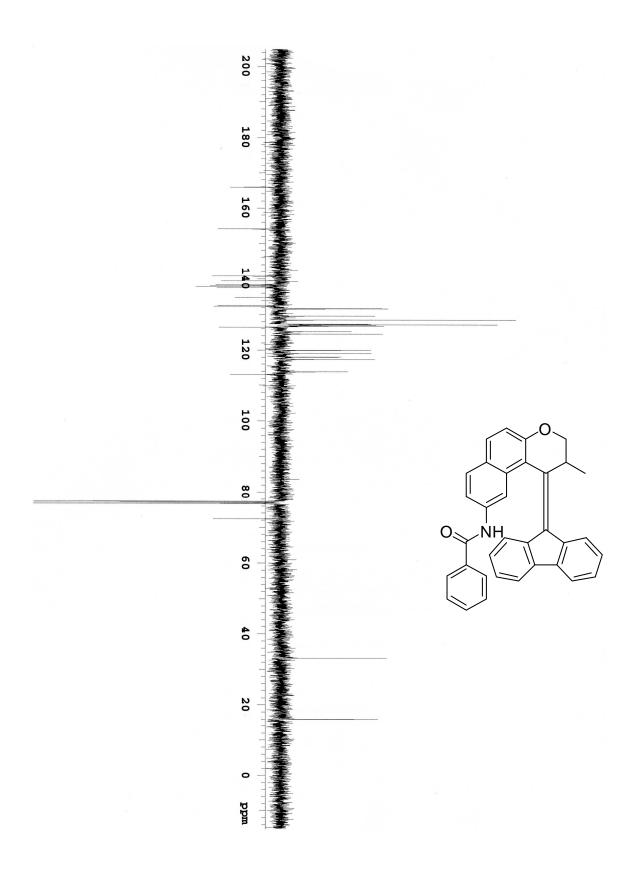


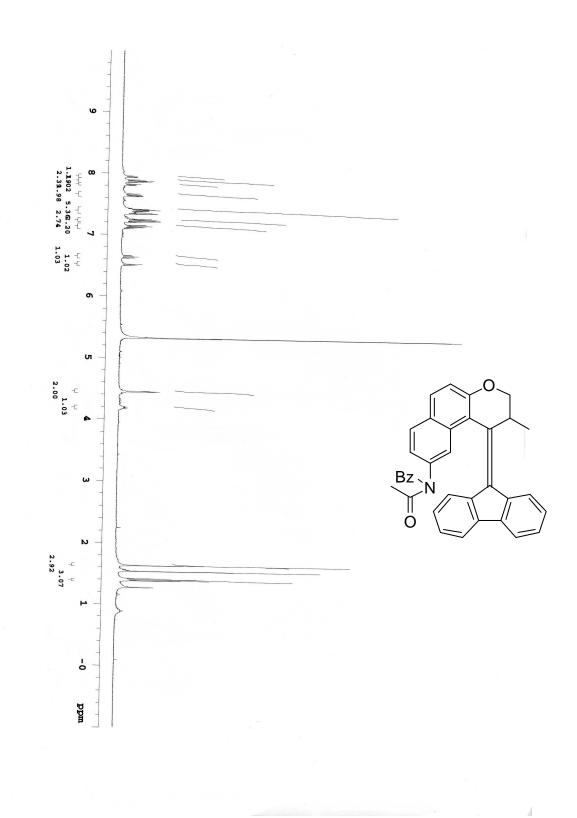


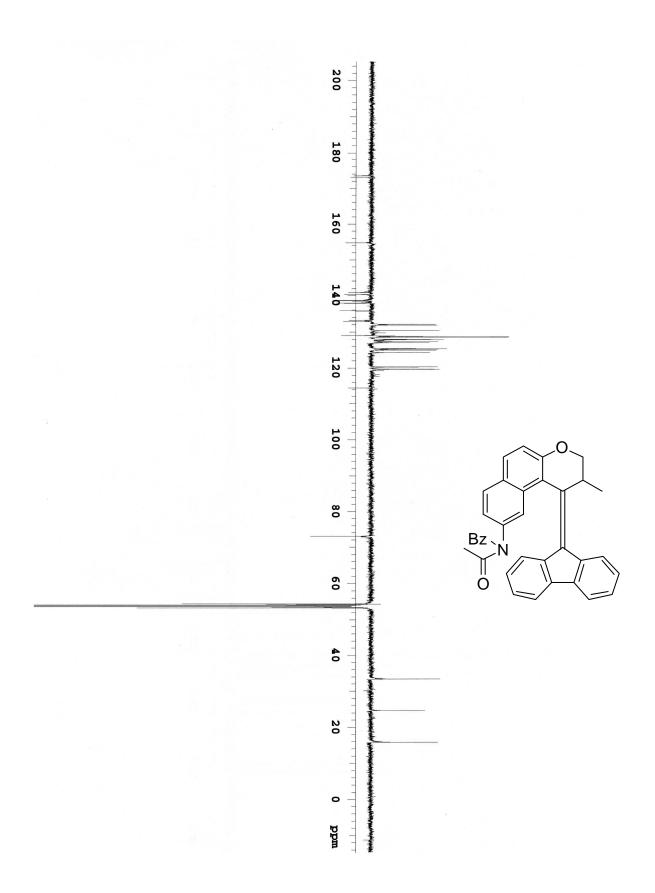


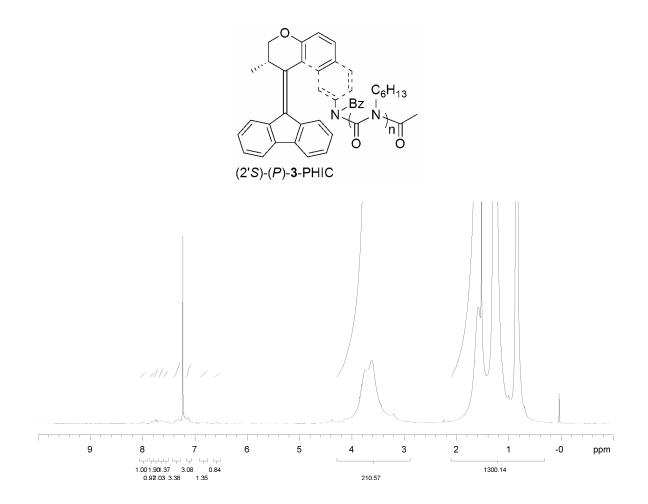


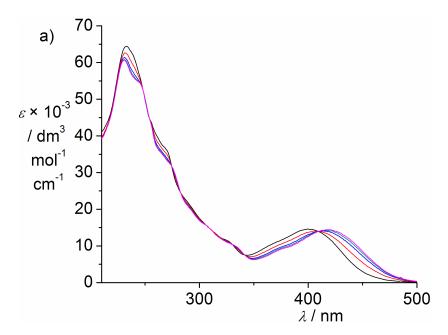




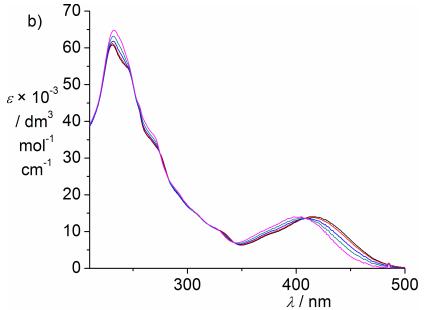








UV/vis spectra (Et₂O, 20°C) of (2'S)-(P)-2 (black line), the mixture with (2'S)-(P)-2 and (2'S)-(M)-2 after 1 min (red), 2 min (blue), 3 min (green), and the PSS mixture after 10 min (magenta) of UV irradiation ($\lambda = 365$ nm); clear isosbestic points are observed at 274, 342 and 409 nm.



UV/vis spectra (Et₂O, 20°C) of the PSS mixture with (2'S-(P)-2 and (2'S-(M)-2 after 10 min of UV irradiation ($\lambda = 365$ nm) (black line), the mixture after 45 min (red), 90 min (blue), 150 min (green), and the PSS mixture after 300 min (magenta) of visible light irradiation ($\lambda > 480$ nm); clear isosbestic points are observed at 274, 342 and 409 nm.

Crystal data and details of the structure determination of $(2^{\circ}S^{*})-(P^{*})-2$ and $(2^{\circ}S^{*})-(M^{*})-2$.

Moiety_Formula	C ₃₄ H ₂₅ NO ₂
Formula_Weight, g.mol ⁻¹	479.58
Crystal system	orthorhombic
Space group, no.	P2 ₁ 2 ₁ 2 ₁ , 19
<i>a</i> , Å	9.1089 (13)
<i>b</i> , Å	13.2614 (18)
<i>c</i> , Å	19.958 (3)
<i>V</i> , Å	2410.9 (6)
Θ range unit cell: minmax., deg; reflections	2.55 - 27.31 ; 6046
Formula_Z	4
SpaceGroup_Z	4
Z' (= Formula_Z / SpaceGroup_Z)	1
ρ_{calc} , g.cm ⁻³	1.321
F(000), electrons	1008
$\mu(Mo \ K \overline{\alpha})$, cm ⁻¹	0.81
Color, habit	orange, block
Approx. crystal dimension, mm	0.37 x 0.14 x 0.12

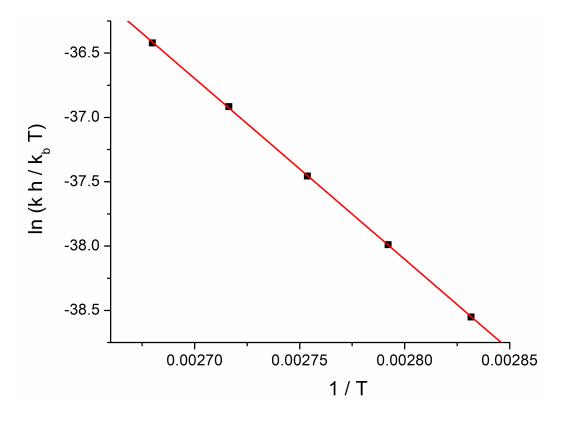
a. Data collection.

λ (Mo K $\overline{\alpha}$), Å	0.71073
Monochromator	Graphite
Measurement device type	Bruker SMART APEX
	CCD area-detector diffractometer
Detector Area resolution (pixels / mm)	4096 x 4096 / 62 x 62 (binned 512)
Temperature, K	100 (1)
Measurement method	φ - and ω -scans
θ range; min. max., deg	2.46, 25.34
Index ranges	h: -10→10; k: -15→14; l: -22→23
Min Max. absorption transmission factor	0.9603 - 0.9903
X-ray exposure time, h	16.6 (30 sec / frame)
Total data	15811
Unique data	2495
Data with criterion: $(F_o \ge 4.0 \sigma (F_o))$	2145
$R_{int} = \sum \left[F_o^2 - F_o^2(mean) \right] / \sum \left[F_o^2 \right]$	0.0701
$R_{sig} = \sum \sigma(F_o^2) / \sum [F_o^2]$	0.0645

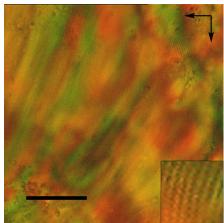
b.Refinement.

Number of reflections	2495
Number of refined parameters	431
Final agreement factors:	
$wR(F^{2}) = \left[\sum \left[w(F_{o}^{2} - F_{c}^{2})^{2}\right] / \sum \left[w(F_{o}^{2})^{2}\right]\right]^{1/2}$	0.0997
Weighting scheme: a, b	0.0, 1.4636
w = $1/[\sigma^{2}(F_{o}^{2}) + (aP)^{2} + bP]$ And P = $[max(F_{o}^{2}, 0) + 2F_{c}^{2}] / 3$	
And P = $[max(F_o^2, 0) + 2F_c^2] / 3$	
$\mathbf{R}(\mathbf{F}) = \sum (\mathbf{F}_{o} - \mathbf{F}_{c}) / \sum \mathbf{F}_{o} $	0.0461
For $F_o > 4.0 \sigma$ (F_o)	
GooF = S = $\left[\sum \left[w(F_o^2 - F_c^2)^2\right] / (n-p)\right]^{1/2}$	1.068
n = number of reflections	
p = number of parameters refined	
Residual electron density in final	
Difference Fourier map, e/Å ³	-0.40, 0.36 (4)
Max. (shift/ σ) final cycle	< 0.001
Average (shift/ σ) final cycle	< 0.001

Eyring plot for the thermal conversion of $(2^{\circ}S)-(M)-2$ to $(2^{\circ}S)-(P)-2$:

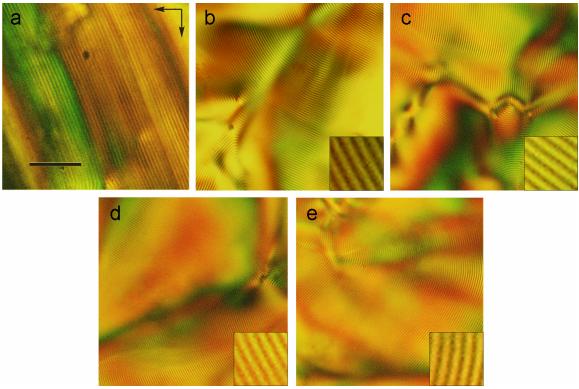


Increase in concentration of a LC film from 30 wt% to 40 wt% of $(2^{\circ}S)-(P)$ -3-PHIC in toluene, leading to a decrease in pitch length from 6.0 μ m to 2.9 μ m:



Optical micrograph of a thin film (thickness:200 μ m) of (2'S)-(P)-**3**-PHIC in toluene (40 wt%), $p = 2.9 \ \mu$ m. Scalebar, 50 μ m. The arrows indicate the directions of the crossed polarizers.

Multiple UV ($\lambda = 365$ nm) / visible light ($\lambda > 480$ nm) irradiation cycles, leading to approximately the same final pitch distance after prolonged visible light ($\lambda > 480$ nm) irradiation. The final pitches are much shorter than the initial pitch distance obtained before irradiation: 4.0-4.4 μ m compared to an initial 6.9 μ m:



Optical micrograph of a thin film (thickness: 200 μ m) of a) (2'S)-(P)-**3**-PHIC in toluene (~30 wt%, the concentration is slightly lower than that of the sample used earlier, causing the slightly longer pitch observed, $p = 6.9 \ \mu$ m), b) after a first cycle of 1 h of UV ($\lambda = 365$ nm) and 20 h of visible light ($\lambda > 480$ nm) irradiation ($p = 4.4 \ \mu$ m), c) after a second ($p = 4.1 \ \mu$ m), d) a third ($p = 4.0 \ \mu$ m) and e) a fourth irradiation cycle ($p = 4.2 \ \mu$ m). Scalebar, 50 μ m. The arrows indicate the directions of the crossed polarizers. Insets show a selection under 5x higher magnification.